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INEO	RMATION I)ICC	OSTIDE	Application Number	10/815,653
-				Filing Date	April 2, 2004
SIAI	TEMENT BY			First Named Inventor	Shunpei Yamazaki et al.
	(use as many sheets o	as necesso	ary)	Group Art Unit	2826
				Examiner Name	Ahmed N. Sefer
Sheet	1	of	1	Attorney Docket Number	. 0756-7280

			-	U.S. PATENT DOCUMEN	rs	
Examiner Initials	Cite No.	U.S. Patent Docu	iment	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
			Cind Code ² if known)			
AS		5,421,908		Yoshida et al.	06/06/1995	
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Examiner Initials	Cite No.1	Foreign Patent Document				Name of Patentee or	Date of Publication of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant	
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

[·] Unique citation designation number. ² Applicant is to place a check mark here if English language Translation is attached.

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AS		US 5,526,149	Kanbe et al.	06/11/1996	·
					
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				FOREIGN PATENT DOC	UMENTS		
Examiner Initials	Cite No.3		Foreign Patent Document Kind Code ³	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁴
		Office ³	Number ⁴ (if known)	Applicant of Cited Document		Figures Appear	
AS		JP	03-004214		01/10/1991		Abst.
AS		JP	06-075237		03/18/1994		Abst.
AS		EP	0 586 220		03/09/1994		Eng.
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Substit	for form 1449A/PTO			C	omplete If Known
MARKE	DMATION I) ico	OCUIDE	Application Number	10/815,653
	INFORMATION DISCLOSURE STATEMENT BY APPLICANT			Filing Date	April 2, 2004
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				Examiner Name	Unassigned
Sheet	1	of	1	Attorney Docket Number	0756-7280

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		Number	Kind Code ¹ (If known)	Document	MM-DD-1111		
Α	S		4,065,781		Gutknecht	12/27/1977	
		-	4,954,985		Yamazaki	09/04/1990	
			5,247,191		Yamazaki et al.	09/21/1993	
			5,470,681		Brunner et al.	11/28/1995	
			5,481,432		Tsukada et al.	01/02/1996	
			5,747,928		Shanks et al.	05/05/1998	
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					FOREIGN PATENT DOC	UMENIS	· · · · · · · · · · · · · · · · · · ·	
Examiner Initials*	Cite No.1	Foreign Patent Document			Name of Patentee or	Date of Publication of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant	
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			Code ²	Document	MCM-DD-YYYYY		
AS		5,032,883	T	Wakai et al.	07/16/1991		
AS		5,456,763		Kaschmitter et al.	10/10/1995		
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Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.)., date, page(s), volume-issue number(s), publisher, city and/or country where published.						
AS		Offici	Official Action for U.S. Application Serial No. 10/925,980 dated February 7, 2005.					
AS		C. YEH, Novel Technique for SiO ₂ Formed by Liquid-Phase Deposition for Low- Temperature Processed Polysilicon TFT, IEEE Electron Device Letters, Vol. 14, No. 8, August, 1993, Pages 403-405.						
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